

O I P E 14985
NOV 21 2005
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<p>STANISLAWSKA 1449A/PTO</p> <p>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</p> <p>(use as many sheets as necessary)</p>				Complete if Known	
Sheet 1		of 2	Application Number		10/775,702
			Filing Date		February 9, 2004
			First Named Inventor		Ikuya Yagisawa
			Art Unit		2187
			Examiner Name		Matthew A. Bradley
			Attorney Docket Number		16869N-104800US

U.S. PATENT DOCUMENTS+					
Examiner Initials*	Cite No. ¹	Document Number		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		Number	Kind Code ² (if known)		
MB	1	2005/0060618		03-17-2005	Guha
MB	2	2004/0260987		12-23-2004	Guha et al.
MB	3	2004/0180183		09-30-2004	Tamai et al.
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MB	5	2004/0160975		08-19-2004	Frank et al.
MB	6	6,598,174		07-22-2003	Parks et al.
MB	7	2003/0120863		08-28-2003	Lee et al.
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Examiner Initials*	Cite No. ¹	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		Country Code ³	Number ⁴		

Examiner Signature	Matthew Bradley	Date Considered	1/9/06
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Substitute for form 1449B/PTO				<i>Complete if Known</i>	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT					
(use as many sheets as necessary)					
Sheet	2	of	2		
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Art Unit		2187			
Examiner Name		Matthew A. Bradley			
Attorney Docket Number		16869N-104800US			

NON PATENT LITERATURE DOCUMENTS				
Examiner Initials *	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		
<i>MB</i>	19	ALVAREZ et al. "Tolerating multiple failures in RAID architectures with optimal storage and uniform declustering," Proceedings of the 24th annual international symposium on Computer architecture pp. 62-72 (1997).		
<i>MB</i>	20	COHEN et al. "Segmented information dispersal (SID) for efficient reconstruction in fault-tolerant video servers," Proceedings of the fourth ACM international conference on Multimedia pp.277-286 (1997).		
<i>MB</i>	21	HOU "Comparing rebuild algorithms for mirrored and RAID5 disk arrays," Proceedings of the 1993 ACM SIGMOD international conference on Management of data pp. 317-326 (1993).		
<i>MB</i>	22	MENON et al. "Comparison of sparing alternatives for disk arrays," Proceedings of the 19th annual international symposium on Computer architecture pp. 318-329 (1992).		
<i>MB</i>	23	MOGI et al. "Hot mirroring: a method of hiding parity update penalty and degradation during rebuilds for RAID5," Proceedings of the 1996 ACM SIGMOD international conference on Management of data pp. 183-194 (1996).		
<i>MB</i>	24	MUNTZ et al. "Performance Analysis of Disk Arrays Under Failure," Proceedings of the 16th Conference on Very Large Databases (VLDB) pp.162-173 (1990).		

Examiner Signature	<i>Matthew Bradley</i>	Date Considered	<i>11/9/06</i>
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Information Disclosure Statement by Applicant (use as many sheets as necessary)				<i>Complete if Known</i>	
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				Art Unit	2187
				Examiner Name	M. Bradley
				Attorney Docket Number	16869N-104800US

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		Number	Kind Code ² (if known)		
MB	1	US-6,324,654		11-27-2001	Wahl et al.
MB	2	US-5,734,818		03-31-1998	Kern et al.

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Examiner Initials*	Cite No. ¹	Foreign Patent Document			Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code ³	Number ⁴	Kind Code ⁵ (if known)	

Examiner Signature	<i>M. Bradley</i>	Date Considered	1/20/06
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